TOSHIBA Bipolar Linear Integrated Circuit Silicon Monolithic

# TA75W393FU

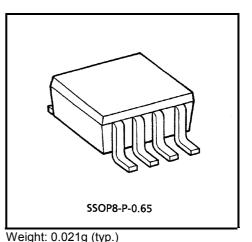
#### Dual Voltage Comparator

This device consist of two independent voltage comparators that designed to operate from a single power supply over a wide range of voltage.

Normal operation from dual supplies is also to be guaranteed on voltage range from  $\pm$  1V to  $\pm$  18V.

 $V_{\mbox{CC}}$  is necessary at least more 1.5V volts than the input common mode voltage.

The output can be connected to other open collector outputs to achieve Wired-OR relation ship.

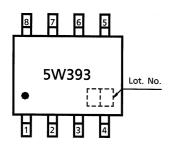


#### Features

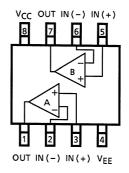
- Compatible to TA75393.
- Single supply voltage range or dual supplies
- Low supply current
- Low input offset voltage

- : 2VDC to 36VDC or ± 1VDC to ± 18VDC : 0.8mA (typ.)
- $\pm 2mV$  (typ.)
- Wide input common mode voltage range  $: 0V_{DC}$  to  $V_{CC} 1.5V_{DC}$
- Output compatible with TTL, DTL, MOS and CMOS logic system.
- The output can be connected to achieve Wired-OR relation..

#### Marking (Top View)

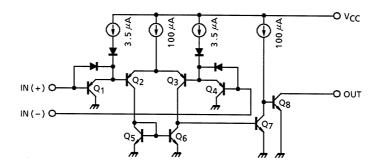


#### Pin Connection (Top View)



# <u>TOSHIBA</u>

### Equivalent Circuit



### Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit	
Supply voltage	$V_{CC}, V_{EE}$	±18 or 36	V	
Differential input voltage	DVIN	±36	V	
Input voltage	V <sub>IN</sub>	+0.3~V <sub>CC</sub>	V	
Power dissipation	PD	250	mW	
Operating temperature	T <sub>opr</sub>	-40~85	°C	
Storage temperature	T <sub>stg</sub>	-55~125	°C	

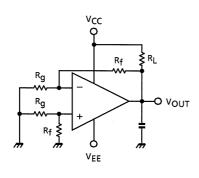
#### Electrical Characteristics ( $V_{CC} = 5V$ , $V_{EE} = GND$ , Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Input offset voltage	V <sub>IO</sub>	1	—	—	2	5	mV
Input bias current	lį	2	—	—	25	250	nA
Input offset current	l <sub>IO</sub>	2	—	—	5	50	nA
Common mode input voltage	CMVIN	_	—	0	_	V <sub>CC</sub> -1.5	V
Supply current	ICC	3	No load	—	0.8	2	mA
Voltage gain	GV	_	R <sub>L</sub> = 15kΩ	—	200	—	V/mA
Sink current	I <sub>sink</sub>	4	IN (+) = $0V_{DC}$ , IN (-) = $1V_{DC}$ $V_{OL}$ = 1.5V	6	16	_	nA
Output Voltage ("L" Level)	V <sub>OL</sub>	5	$IN (+) = 0V_{DC}, IN (-) = 1V_{DC}$ $I_{sink} = 3mA$	_	0.2	0.4	V
Output Leak Current	ILEAK	_	$      IN (+) = 1V_{DC}, IN (-) = 0V_{DC}       V_O = 5V_{DC} $	_	0.1	_	nA
Response Time	t <sub>rsp</sub>	6	R <sub>L</sub> = 5.1kΩ, C <sub>L</sub> = $15_{pF}$	_	1.3	_	μs

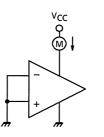
### **TOSHIBA**

#### Test Circuit

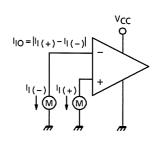
(1) V<sub>IO</sub>



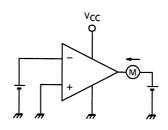
(3) I<sub>CC</sub>





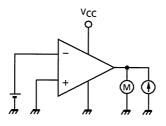


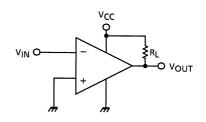
(4) I<sub>sink</sub>



(5) V<sub>OL</sub>

(6) t<sub>rsp</sub>





# <u>TOSHIBA</u>

0 - 40

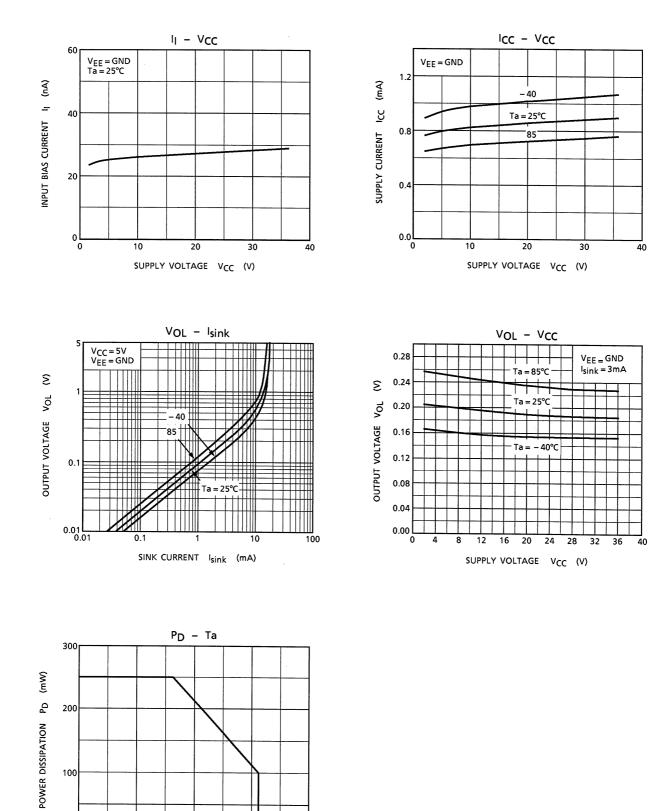
0

40

AMBIENT TEMPERATURE Ta (°C)

80

120

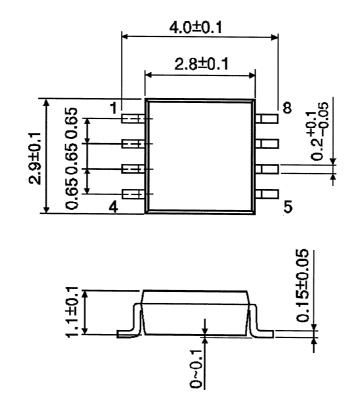


### **TOSHIBA**

#### Package Dimensions

SSOP8-P-0.65

Unit: mm



Weight: 0.021g (typ.)

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